## **WEST Search History**

Hide Items Restore Clear Cancel

DATE: Tuesday, January 06, 2004

Hide? Set Name Query  DB=USPT, EPAB, JPAB, DWPI, TDBD; PLUR=YES; OP=OR			
	DB=US	PT,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR	
	L2	(linear near3 combin\$8) and (comma near2 free near2 code\$)	1
	L1	(linear near3 combin\$8) and ((cfc) or(comma near2 free near2 code\$))	21

**END OF SEARCH HISTORY** 

f

## **WEST Search History**

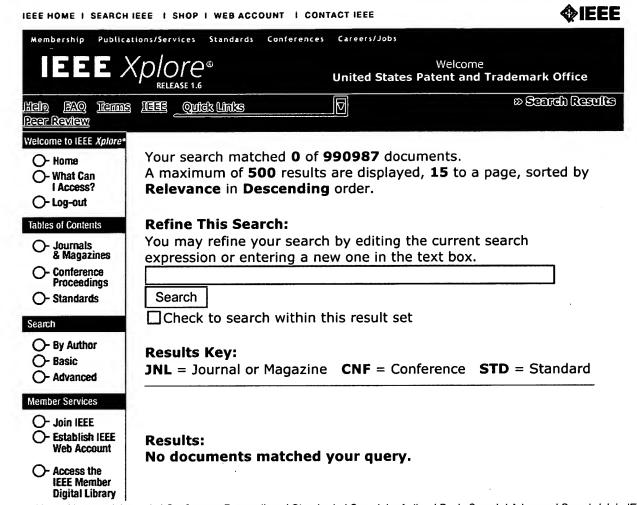
Hide Items | Restore | Clear | Cancel

DATE: Tuesday, January 06, 2004

Hide?	Set Nam	e Query	Hit Count
	DB = US	SPT,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR	
	L2	(linear near3 combin\$8) and (comma near2 free near2 code\$)	1
	L1	(linear near3 combin\$8) and ((cfc) or(comma near2 free near2 code\$))	21

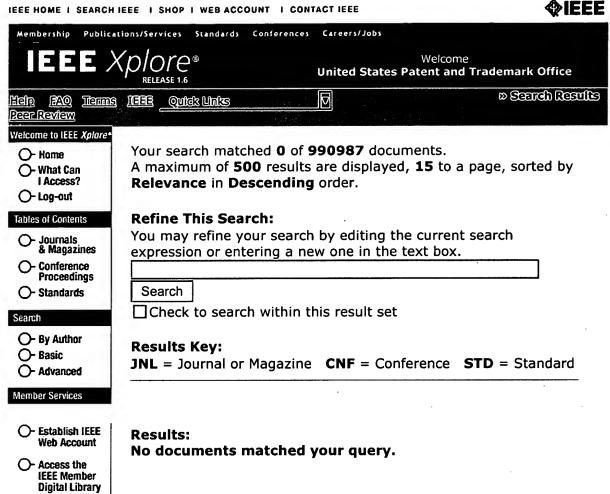
**END OF SEARCH HISTORY** 

	Туре	L #	Hits	Search Text	DBs	Time Stamp	Comment
1	IS&R	L1	0	<pre>("(linearnear2combina tion\$) same2((cfc)or(c ommaadj2freeadj2code\$ ))").PN.</pre>		2004/01/0 6 08:27	
2	IS&R	L2	0	<pre>("(linearnear2combin\$ 8) same2((cfc)or(comma near2freeanear2code\$) ) ") .PN.</pre>	USPA	2004/01/0 6 08:28	
3	IS&R	L3	0	<pre>("(linearnear2combin\$ 8) and((cfc) or (commane ar2freeanear2code\$))" ).PN.</pre>	USPA	2004/01/0 6 08:28	



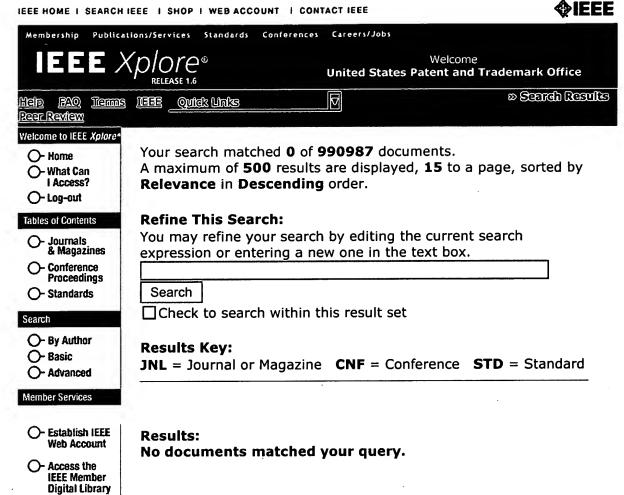
Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE - All rights reserved



Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ| Terms | Back to Top

Copyright @ 2004 IEEE - All rights reserved



Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ| Terms | Back to Top

Copyright © 2004 IEEE --- All rights reserved